

NOT RECOMMENDED FOR NEW DESIGN **USE DMN63D1LDW**



2N7002DWKX

DUAL N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON)}	Package	I _D T _A = +25°C
60V	8Ω @ V _{GS} = 5V	SOT363	170mA
000	6Ω @ V _{GS} = 10V	301303	200mA

Description

This new generation MOSFET has been designed to minimize the on-state resistance (RDS(ON)) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- **DC-DC Converters**
- **Power Management Functions**
- Battery Operated Systems and Solid-State Relays
- Drivers: Relays, Solenoids, Lamps, Hammers, Displays, Memories, Transistors, etc

Features

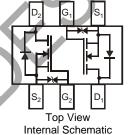
- **Dual N-Channel MOSFET**
- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Small Surface Mount Package
- ESD Protected up to 2kV
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SOT363
- Case Material: Molded Plastic. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Matte Tin Finish annealed over Alloy 42 leadframe (Lead Free Plating). Solderable per MIL-STD-202, Method 208 (3)
- Terminal Connections: See Diagram
- Weight: 0.006 grams (approximate)







Top View

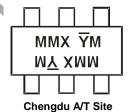
Ordering Information (Note 4)

Part Number	Case	Packaging
2N7002DWKX-7	\$OT363	3,000/Tape & Reel
2N7002DWKX-13	SOT363	10,000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain < 900ppm bromine, < 900ppm chlorine (< 1500ppm total Br + Cl) and <1000ppm antimony compounds.
 For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information





MMX = Product Type Marking Code

YM = Date Code Marking for SAT (Shanghai Assembly/ Test site) YM = Date Code Marking for CAT (Chengdu Assembly/ Test site)

Y or \overline{Y} = Year (ex: A = 2013) M = Month (ex: 9 = September)

Date Code Key

Year	201	2	2013		2014	20	15	2016		2017	2	018
Code	Z		Α		В	(0	D		Е		F
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Drain-Source Voltage	V _{DSS}	60	V		
Gate-Source Voltage			V _{GSS}	±20	V
Continuous Drain Current (Note 5) V _{GS} = 10V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	180 140	mA
Continuous Drain Current (Note 5) V _{GS} = 5V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	ID	150 120	mA
Continuous Drain Current (Note 6) V _{GS} = 10V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	ID	200 160	mA
Continuous Drain Current (Note 6) V _{GS} = 5V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	ID	170 140	mA
Maximum Continuous Body Diode Forward Current (Note	Is	0.5	Α		
Pulsed Drain Current (10µs pulse, duty cycle = 1%)	I _{DM}	700	mA		

Thermal Characteristics

Symbol	Value	Units
P_{D}	300	mW
R _{θJA}	435	°C/W
P _D	400	mW
$R_{\theta JA}$	316	°C/W
$R_{ heta JC}$	139	°C/W
T_{J} , T_{STG}	-55 to +150	°C
	P _D R _{BJA} P _D R _{BJA} R _{BJC}	P _D 300 R _{BJA} 435 P _D 400 R _{BJA} 316 R _{BJC} 139

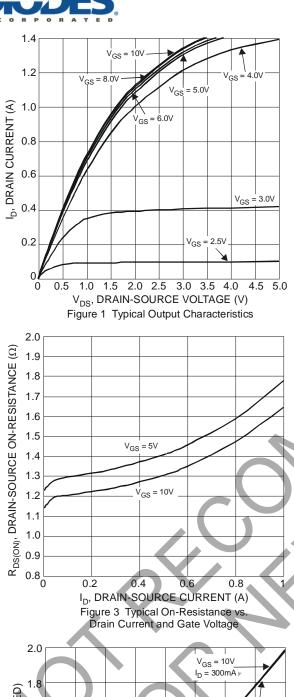
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

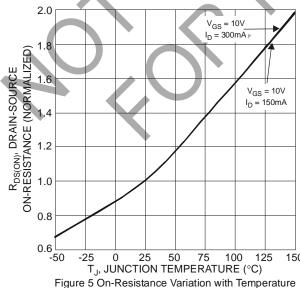
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV _{DSS}	60			V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	ì		1.0	μΑ	$V_{DS} = 60V$, $V_{GS} = 0V$	
Gate-Body Leakage	I _{GSS}			±10	μΑ	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V _{GS(th)}	8.0	_	2.5	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$	
Static Drain-Source On-Resistance			_	6	Ω	$V_{GS} = 10V, I_D = 0.5A$	
Static Dialii-Source Off-Resistance	R _{DS(ON)}			8	Ω	$V_{GS} = 5V, I_D = 0.05A$	
Forward Transconductance	g FS	80	_	_	mS	$V_{DS} = 10V, I_D = 0.115A$	
Diode Forward Voltage	V_{SD}		0.8	1.2	٧	$V_{GS} = 0V, I_{S} = 115mA$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C _{iss}	l	56				
Output Capacitance	Coss		4.4		pF	$V_{DS} = 25V, V_{GS} = 0V, f = 1.0MHz$	
Reverse Transfer Capacitance	C _{rss}		3.1				
Gate Resistance	R_{G}		88		Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$	
Total Gate Charge V _{GS} = 10V	Q_g		1.4				
Total Gate Charge V _{GS} = 4.5V	Q_{g}	l	0.6	l	nC	$V_{GS} = 4.5V, V_{DS} = 10V,$	
Gate-Source Charge	Q_{gs}		0.2	_	IIC	$I_D = 250 \text{mA}$	
Gate-Drain Charge	Q_{gd}	_	0.1	_			
Turn-On Delay Time	t _{D(on)}	_	3.0	_		V _{DD} = 30V, V _{GS} = 10V,	
Turn-On Rise Time	t _r	1	2.8	-	nS		
Turn-Off Delay Time	t _{D(off)}	1	17.4		113	$R_G = 25\Omega$, $I_D = 200$ mA	
Turn-Off Fall Time	tf	_	8.1	-			

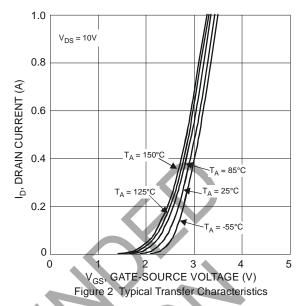
Notes:

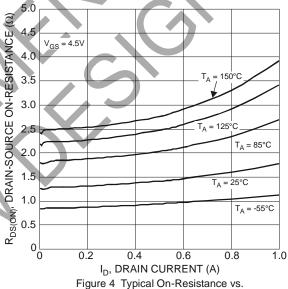
- Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.
 Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper pad layout
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to production testing.

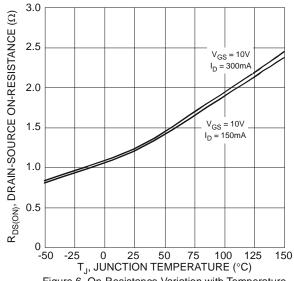












Drain Current and Temperature

Figure 6 On-Resistance Variation with Temperature



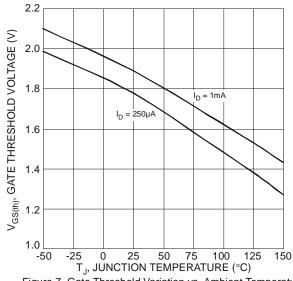
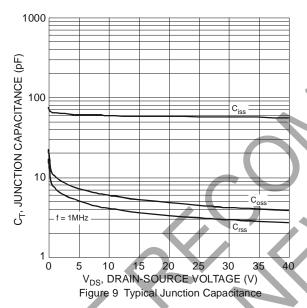
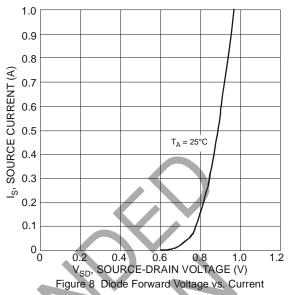
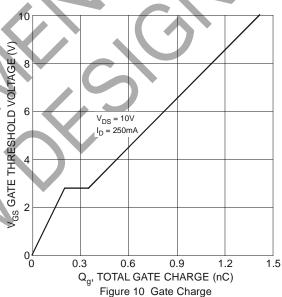


Figure 7 Gate Threshold Variation vs. Ambient Temperature

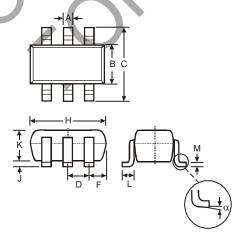






Package Outline Dimensions

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.

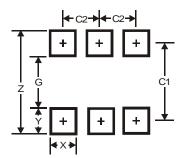


SOT363						
Dim	Min Max					
Α	0.10	0.30				
В	1.15 1.35					
С	2.00	2.20				
D	0.65 Typ					
F	0.40 0.45					
Н	1.80 2.20					
J	0 0.10					
K	0.90 1.00					
L	0.25 0.40					
M	0.10 0.22					
α	0°	8°				
All Dimensions in mm						



Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)				
Z	2.5				
G	1.3				
Х	0.42				
Y	0.6				
C1	1.9				
C2	0.65				

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